Search Notes			

Application/Control No.	Applicant(s)/Patent und Reexamination	Applicant(s)/Patent under Reexamination	
10/044,333	BEN-DVORA ET AL.		
Examiner	Art Unit		
Jason E. Mattis	2616		

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Text search including 370/216,217,218,219,220,221,222,22 3,224,225,226,227,228,241,242,249,4 34	4/26/2006	JM
NPL search including IEEExplore database	4/26/2006	·JM
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